## Notice of References Cited Application/Control No. 10/766,658 Pustelnik et al. Examiner Paul J. Hirsch Applicant(s)/Patent Under Reexamination PUSTELNIK ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,170,567	01-2001	Nakada et al.	165/153
	В	US-6,241,011	06-2001	Nakamura et al.	165/153
	С	US-4,712,612	12-1987	Okamoto et al.	165/146
	D	US-6,220,340	04-2001	Cheong et al.	165/103
	Е	US-6,216,773	04-2001	Falta, Steven R.	165/153
	F	US-5,052,479	10-1991	Nakajima et al.	165/153
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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